



# Application of Residue Sampling to RF/AMS Device Testing

Shogo Katayama, Y. Abe, A. Kuwana

K. Asami, M. Ishida

R. Ohta, H. Kobayashi

*Gunma University*

*Advantest Laboratories Ltd.*

*Advantest Corporation*



# Outline

---

1. Research Objective
2. Residue Sampling
  - Chinese Remainder Theorem
  - Residue Sampling Principle
3. Application to RF/AMS Device Testing
  - Two-Tone Signal Testing
  - High Frequency Narrow-Band Signal Testing
4. Conclusion

# Outline

---

## 1. Research Objective

## 2. Residue Sampling

- Chinese Remainder Theorem
- Residue Sampling Principle

## 3. Application to RF/AMS Device Testing

- Two-Tone Signal Testing
- High Frequency Narrow-Band Signal Testing

## 4. Conclusion

# Research Objective

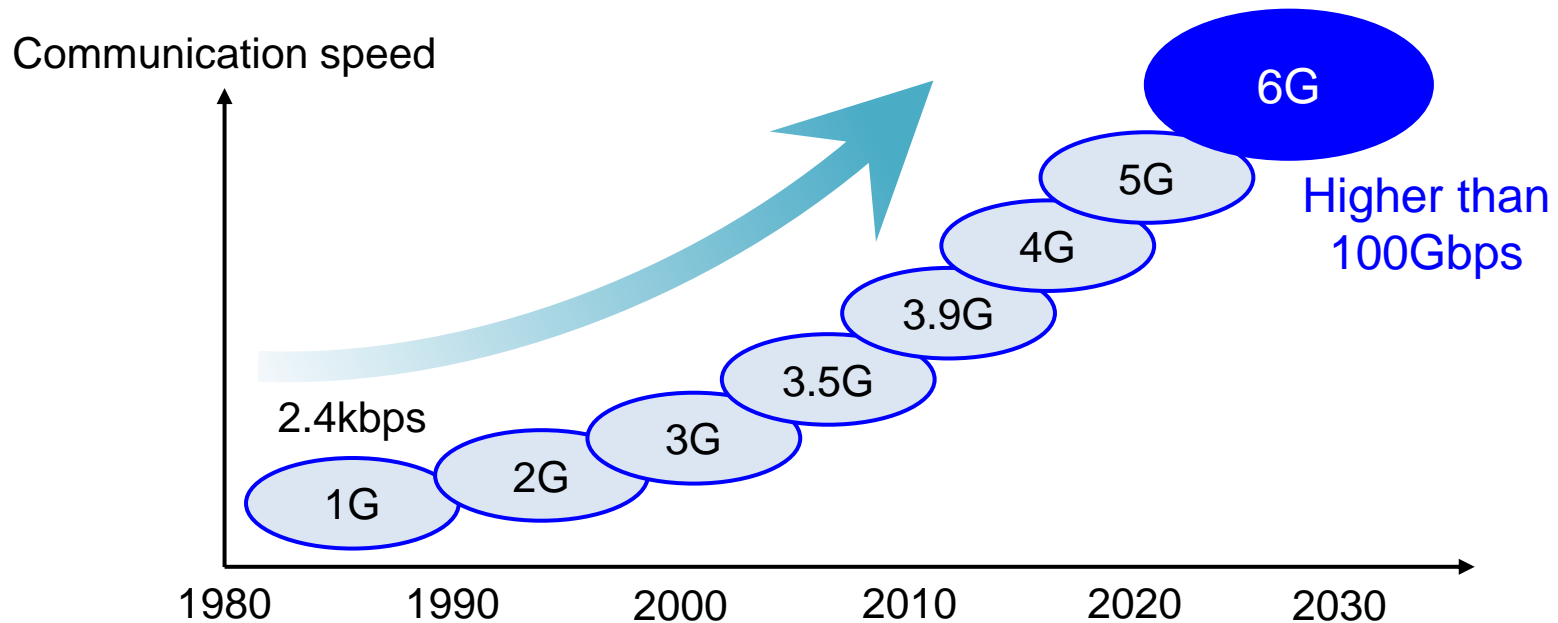
Next Generation Communication System “6G”



High frequencies in communication systems



Development of their efficient testing method



# Research Goal

Low cost testing for high-frequency signals



Application of residue sampling  
to **RF/AMS** device testing

**RF**: Radio Frequency

**AMS**: Analog/Mixed-Signal

## **Residue sampling:**

Measure high-frequency signal  
with **multiple low-frequency** sampling clocks  
utilizing spectrum folding

# Outline

---

1. Research Objective

2. Residue Sampling

- Chinese Remainder Theorem

- Residue Sampling Principle

3. Application to RF/AMS Device Testing

- Two-Tone Signal Testing

- High Frequency Narrow-Band Signal Testing

4. Conclusion

# Chinese Remainder Theorem



Sun Tzu

Chinese arithmetic book  
'Sun Tzu calculation'

孫子算經

"When dividing by 3, its residue is 2,  
dividing by 5, its residue is 3,  
dividing by 7, its residue is 2.  
What is the original number?"

Answer 23

Generalization



Chinese Remainder Theorem



Sun Tzu calculation

# How to use Chinese remainder theorem

He quickly found out how many soldiers were.



Sun Tzu

“Divide by 3.”

Remainder: 2



...





# How to use Chinese remainder theorem

He quickly found out how many soldiers were.



Sun Tzu

“Divide by 5.”

Remainder: 3



# How to use Chinese remainder theorem

He quickly found out how many soldiers were.



Sun Tzu

“Divide by 7” soldiers in all.”





# Outline

1. Research Objective

2. Residue Sampling

- Chinese Remainder Theorem

- **Residue Sampling Principle**

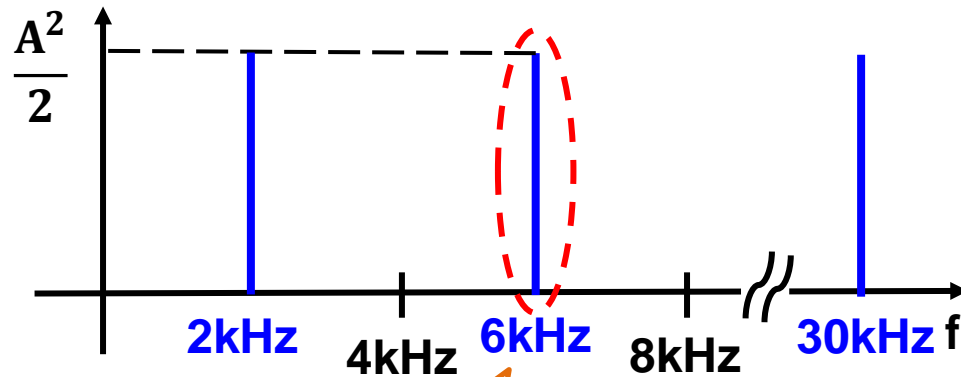
[1] Y. Abe, S. Katayama, C. Li, A. Kuwana, H. Kobayashi, "Frequency Estimation Sampling Circuit Using Analog Hilbert Filter and Residue Number System", IEEE ASICON (Oct. 2019).

# Spectrum Folding by Sampling

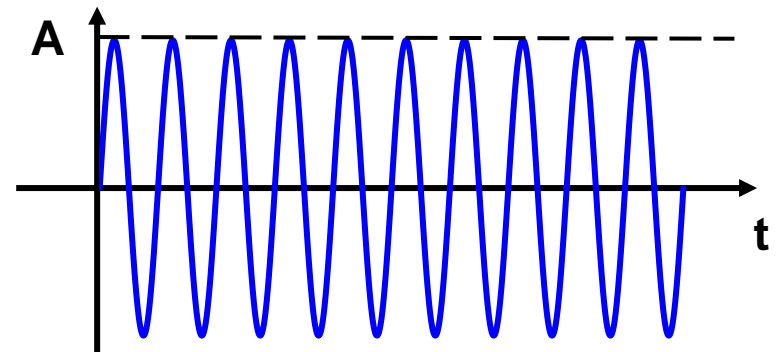
Sampling frequency : 8 kHz

FFT

Spectrum is folded  
within sampling frequency band



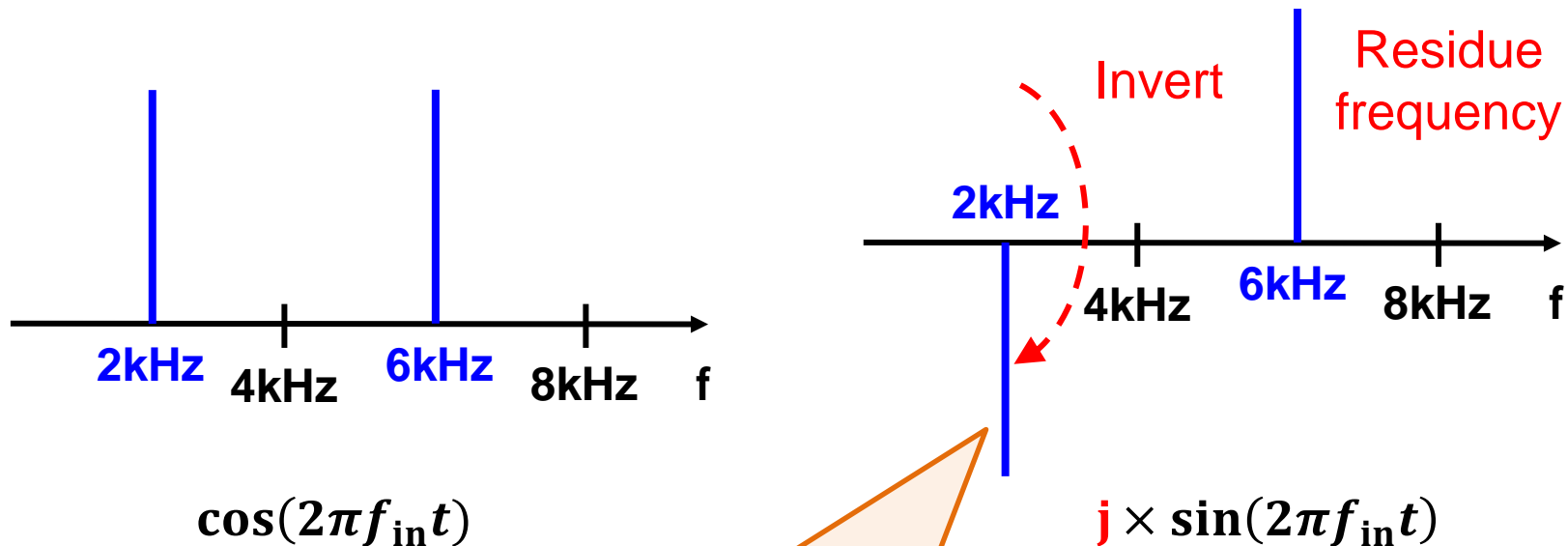
Waveform frequency : 30kHz



Residue frequency  
 $\text{mod}_8 30 = 6$

# Complex FFT of $j \times \sin(2\pi f_{in} t)$

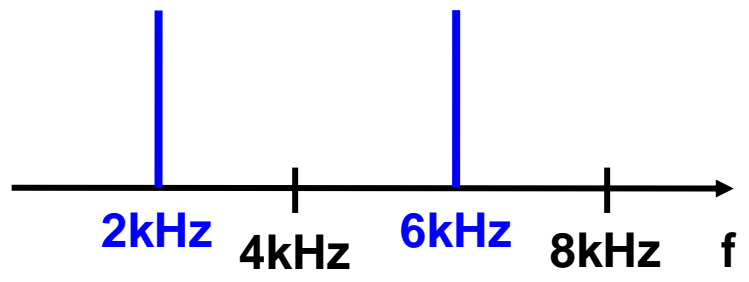
Complex FFT  
 Input frequency : 30 kHz  
 Sampling frequency : 8 kHz



**Inverted spectrum**  
 anti-symmetric at Nyquist frequency

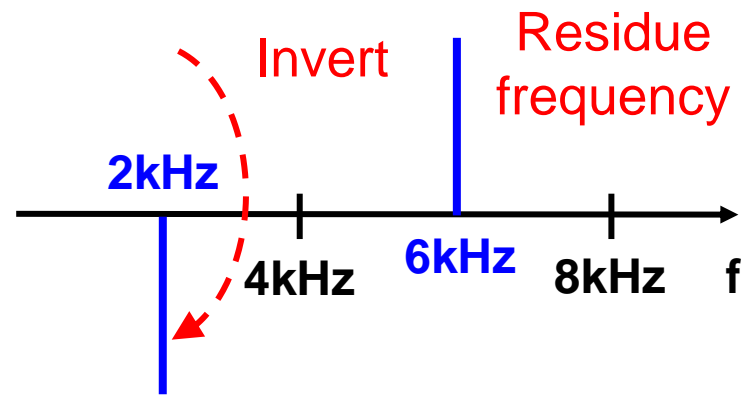
# Complex FFT of $\cos(2\pi f_{in}t) + j \times \sin(2\pi f_{in}t)$

Complex FFT  
Signal : 30 kHz  
Sampling : 8 kHz

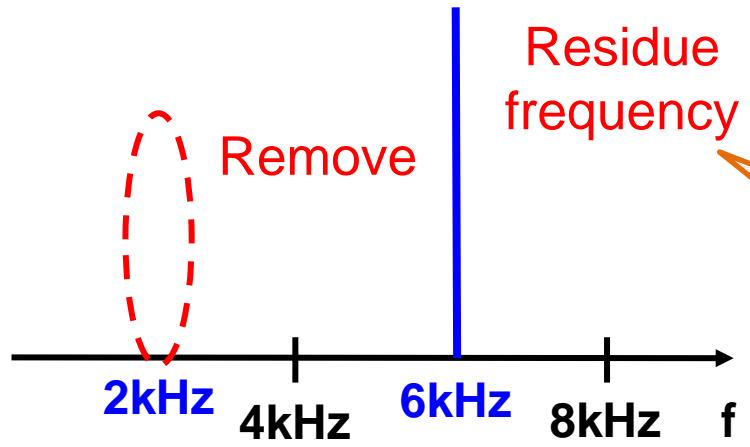


$\cos(2\pi f_{in}t)$

+



$j \times \sin(2\pi f_{in}t)$



$\cos(2\pi f_{in}t) + j \times \sin(2\pi f_{in}t)$

Extract spectrum of residue frequency

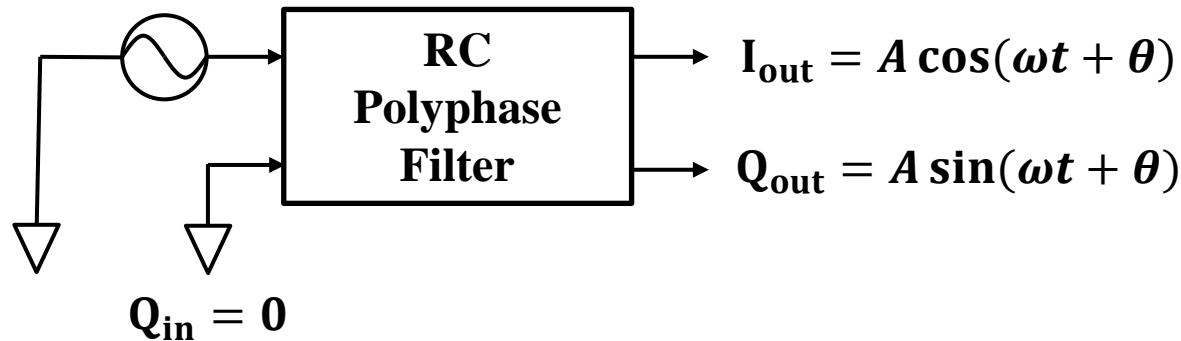
# How to Generate $j \times \sin(2\pi f_{in} t)$

Use analog Hilbert filter



RC polyphase filter

$$I_{in} = \cos(\omega t)$$



Generate **in-phase** and **quadrature** waves  
from a cosine wave



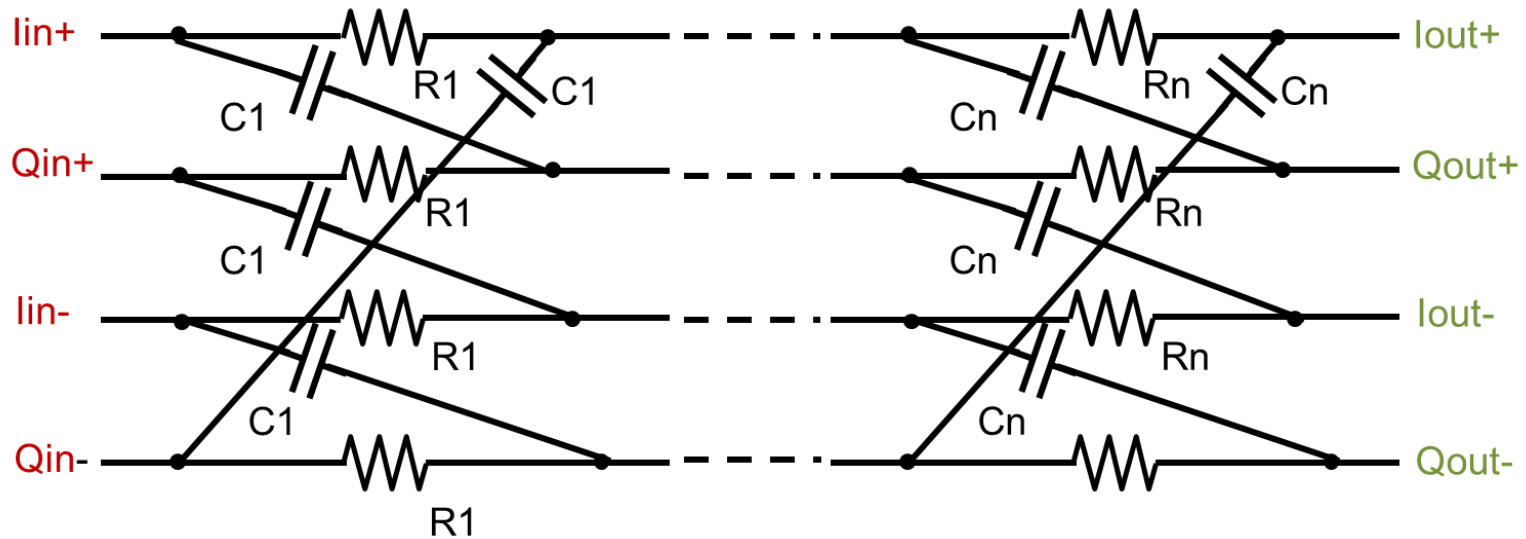
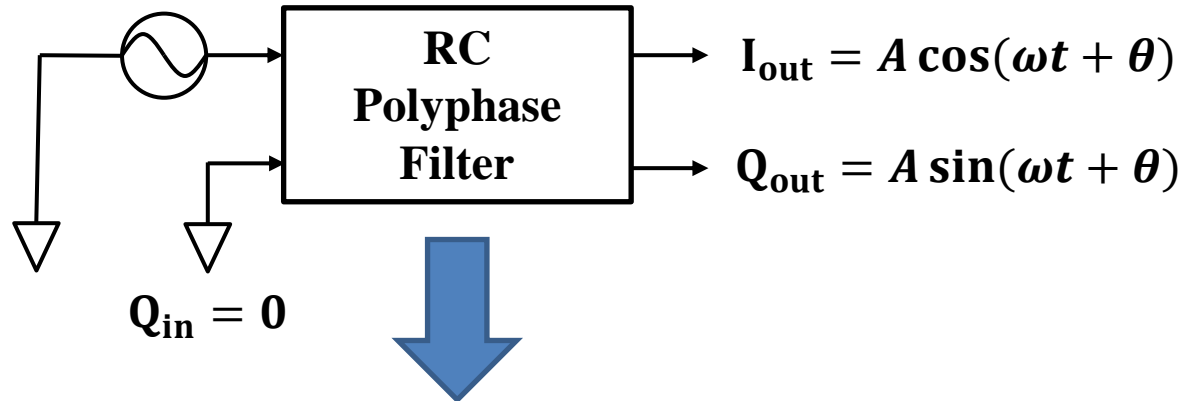
David Hilbert  
1862 - 1943

- [2] Y. Tamura, R. Sekiyama, K. Asami, H. Kobayashi,  
"RC Polyphase Filter As Complex Analog Hilbert Filter", IEEE ICSICT (Oct. 2016).



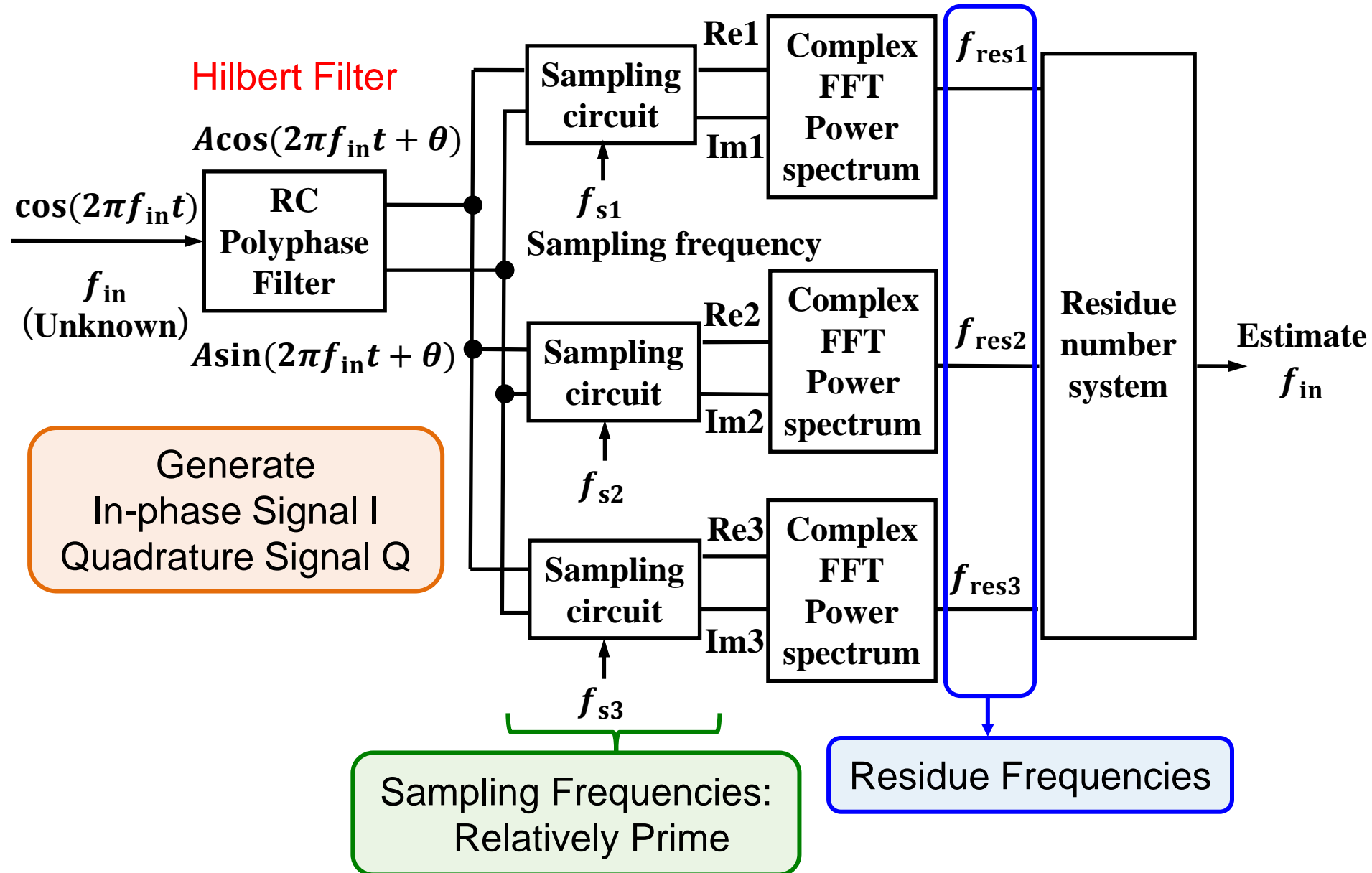
# RC Polyphase Filter

$$I_{in} = \cos(\omega t)$$



Passive analog bandstop filter

# Residue Sampling Circuit



# Frequency Estimation by Residue Number System

Residue frequencies

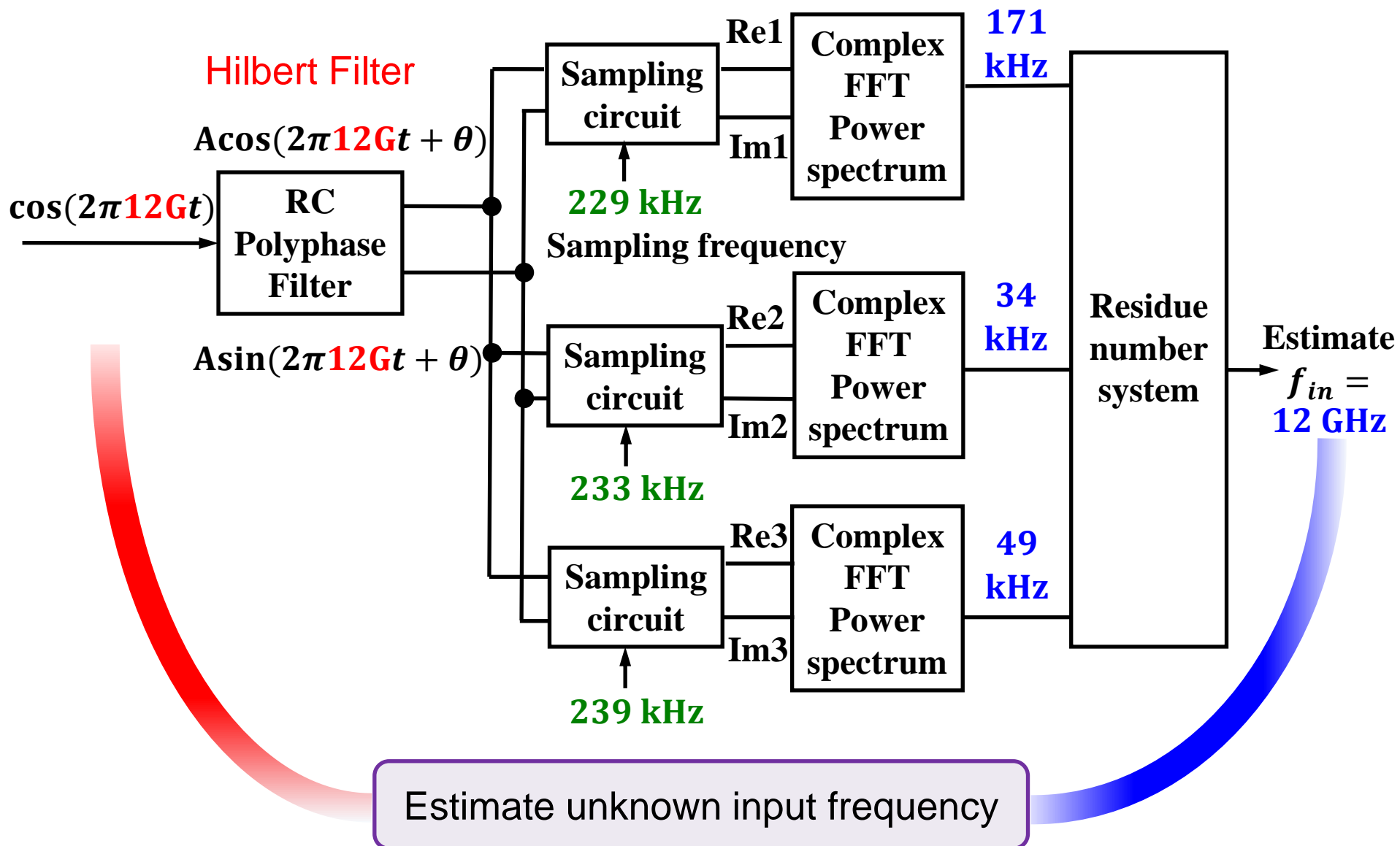
171 kHz, 34 kHz, 49 kHz

Input frequency estimation  
using residue frequencies  
and residue number system

Estimate input frequency **12 GHz**

a [kHz]	b [kHz]	c [kHz]	k [kHz]
0	0	0	0
1	1	1	1
2	2	2	2
⋮	⋮	⋮	⋮
169	31	47	11999998
170	32	48	11999999
171	34	49	12000000
172	35	50	12000001
173	36	51	12000002
⋮	⋮	⋮	⋮
226	230	235	12752320
227	231	237	12752321
228	232	238	12752322

# Simulation Result Overview



# Frequency Resolution of Residue Sampling

Frequency resolution:  $\frac{f_s}{N} = \frac{1}{t_{\max}}$

$N$ : Sampling points

$t_{\max}$  : Measurement time

$N$ : **large**  $\rightarrow$  Frequency resolution  $\frac{f_s}{N}$  : **fine**

**Fine resolution frequency** measurement can be achieved by taking a **large number of sampled data**

Example : Input signal frequency  $f_{\text{in}} = 19.386$  [kHz]

$f_s$ [kHz]	Theoretical residue frequency [kHz]	Residue frequency [kHz] (bin/number of points)			
		$t_{\max} = 1$ [ms]	$t_{\max} = 10$ [ms]	$t_{\max} = 100$ [ms]	$t_{\max} = 1000$ [ms]
3	<b>1.386</b>	1 (2/3)	1.4 (15/30)	1.39 (140/300)	<b>1.386</b> (1387/3000)
5	<b>4.386</b>	4 (5/5)	4.4 (45/50)	4.39 (440/500)	<b>4.386</b> (4387/5000)
7	<b>5.386</b>	5 (6/7)	5.4 (55/70)	5.39 (540/700)	<b>5.386</b> (5387/7000)
11	<b>8.386</b>	8 (9/11)	8.4 (85/110)	8.39 (840/1100)	<b>8.386</b> (8387/11000)
13	<b>6.386</b>	6 (7/13)	6.4 (65/130)	6.39 (640/1300)	<b>6.386</b> (6387/13000)

# Outline

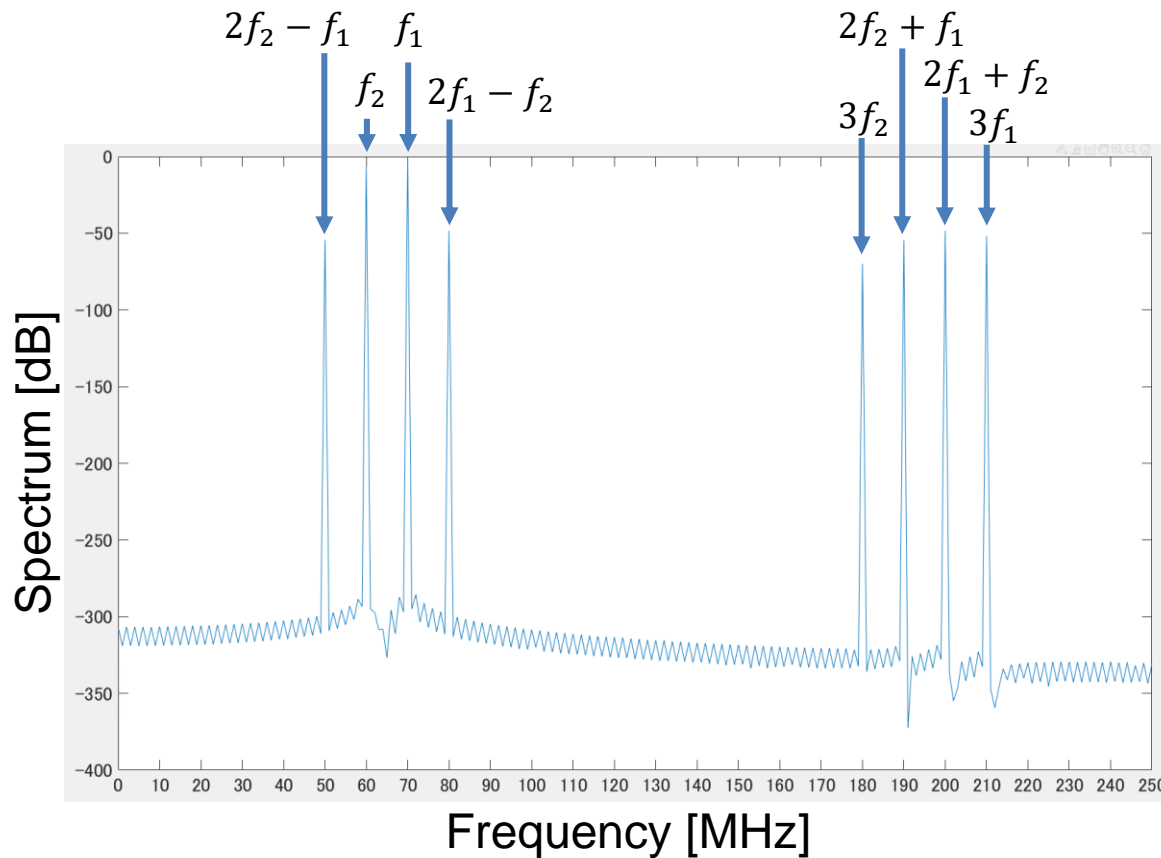
1. Research Objective
2. Residue Sampling
  - Chinese Remainder Theorem
  - Residue Sampling Principle
3. Application to RF/AMS Device Testing
  - **Two-Tone Signal Testing**
  - High Frequency Narrow-Band Signal Testing
4. Conclusion

# Two-Tone Test by Residue Sampling

Consider multi-tone testing for residue sampling.  
First, simulate two-tone test.

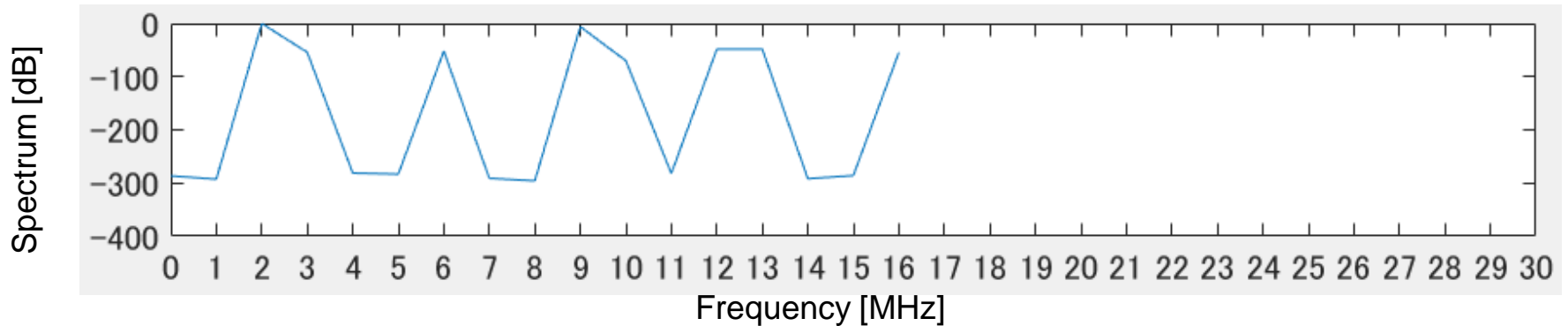
Input:  $x(t) = \cos(2\pi f_1 t) + 0.5 \cos(2\pi f_2 t)$ ,  $f_1 = 70$  MHz,  $f_2 = 60$  MHz

Output:  $y(t) = x(t) - 0.01 x(t)^3$



# Two-Tone Test Simulation ( $f_{s1} = 17 \text{ MHz}$ )

Sampling Frequency:  $f_{s1} = 17 \text{ MHz}$



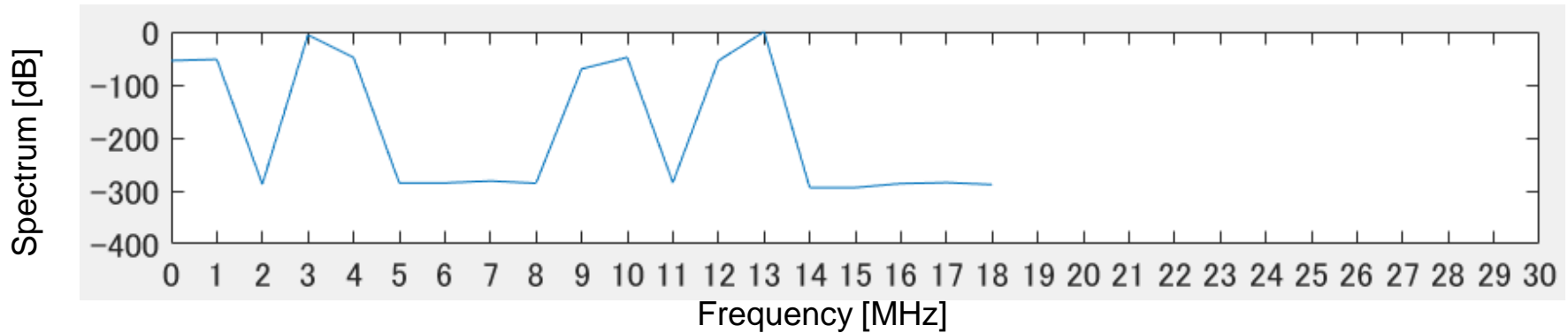
Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$f_1$	70	0.00	2	0.00
$f_2$	60	-6.07	9	-6.07
$3f_1$	210	-51.9	6	-51.9
$3f_2$	180	-70.0	10	-70.0

Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$2f_1 - f_2$	80	-48.4	12	-48.4
$2f_2 - f_1$	50	-54.4	16	-54.4
$2f_1 + f_2$	200	-48.4	13	-48.4
$2f_2 + f_1$	190	-54.4	3	-54.4



# Two-Tone Test Simulation ( $f_{s2} = 19$ MHz)

Sampling Frequency:  $f_{s2} = 19$  MHz

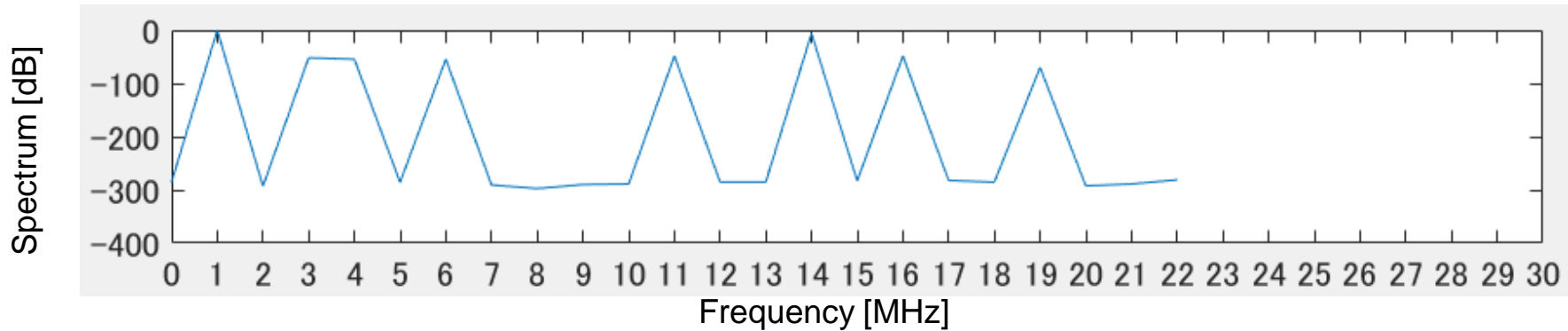


Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$f_1$	70	0.00	13	0.00
$f_2$	60	-6.07	3	-6.07
$3f_1$	210	-51.9	1	-51.9
$3f_2$	180	-70.0	9	-70.0

Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$2f_1 - f_2$	80	-48.4	4	-48.4
$2f_2 - f_1$	50	-54.4	12	-54.4
$2f_1 + f_2$	200	-48.4	10	-48.4
$2f_2 + f_1$	190	-54.4	0	-54.4

# Two-Tone Test Simulation ( $f_{s3} = 23 \text{ MHz}$ )

Sampling Frequency:  $f_{s3} = 23 \text{ MHz}$

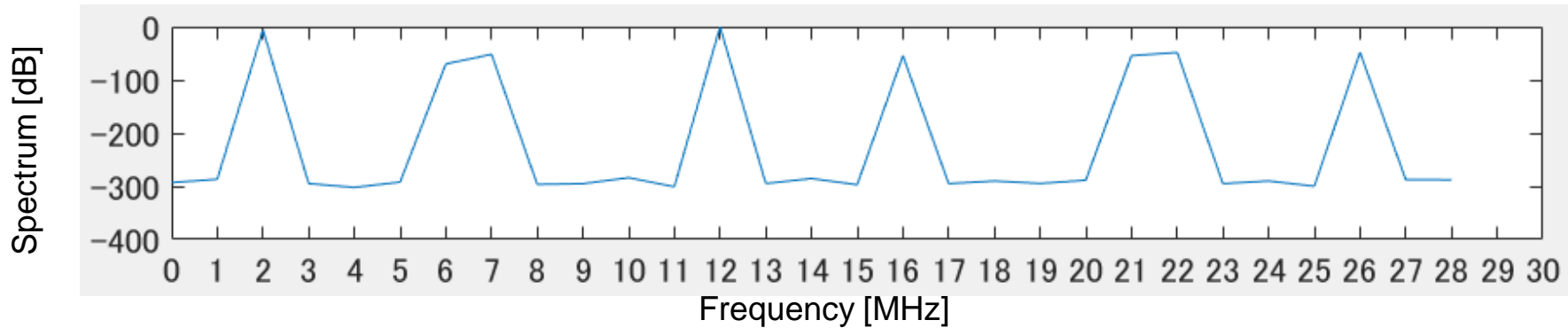


Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$f_1$	70	0.00	1	0.00
$f_2$	60	-6.07	14	-6.07
$3f_1$	210	-51.9	3	-51.9
$3f_2$	180	-70.0	19	-70.0

Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$2f_1 - f_2$	80	-48.4	11	-48.4
$2f_2 - f_1$	50	-54.4	4	-54.4
$2f_1 + f_2$	200	-48.4	16	-48.4
$2f_2 + f_1$	190	-54.4	6	-54.4

# Two-Tone Test Simulation ( $f_{s4} = 29 \text{ MHz}$ )

Sampling Frequency:  $f_{s4} = 29 \text{ MHz}$

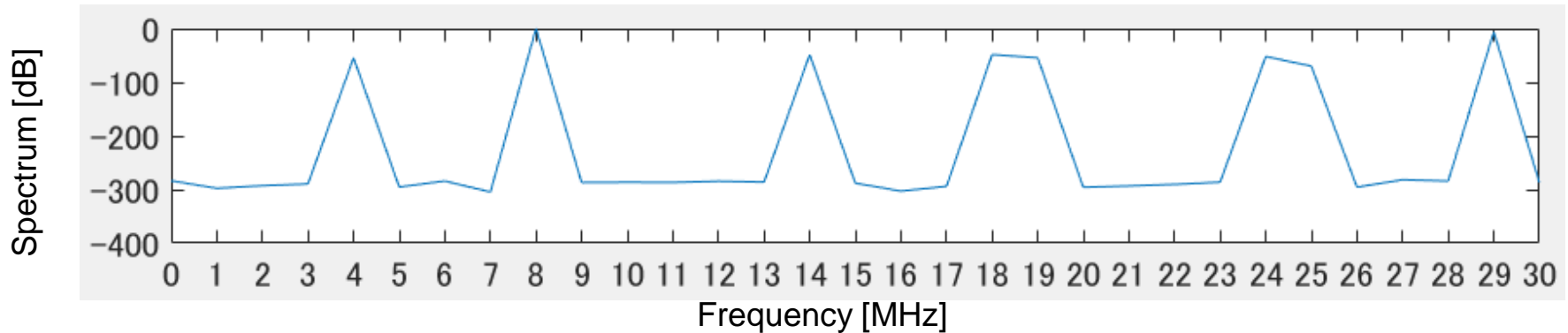


Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$f_1$	70	0.00	12	0.00
$f_2$	60	-6.07	2	-6.07
$3f_1$	210	-51.9	7	-51.9
$3f_2$	180	-70.0	6	-70.0

Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$2f_1 - f_2$	80	-48.4	22	-48.4
$2f_2 - f_1$	50	-54.4	21	-54.4
$2f_1 + f_2$	200	-48.4	26	-48.4
$2f_2 + f_1$	190	-54.4	16	-54.4

# Two-Tone Test Simulation ( $f_{s5} = 31 \text{ MHz}$ )

Sampling Frequency:  $f_{s5} = 31 \text{ MHz}$



Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$f_1$	70	0.00	8	0.00
$f_2$	60	-6.07	29	-6.07
$3f_1$	210	-51.9	24	-51.9
$3f_2$	180	-70.0	25	-70.0

Theory			Simulation	
	Freq. [MHz]	Power [dBc]	Residue freq. [MHz]	Power [dBc]
$2f_1 - f_2$	80	-48.4	18	-48.4
$2f_2 - f_1$	50	-54.4	19	-54.4
$2f_1 + f_2$	200	-48.4	14	-48.4
$2f_2 + f_1$	190	-54.4	4	-54.4

Residue HD, IMD power are the **same** as theoretical HD, IMD power  
Residue sampling is applicable to multi-tone test

# Outline

1. Research Objective
2. Residue Sampling
  - Chinese Remainder Theorem
  - Residue Sampling Principle
3. Application to RF/AMS Device Testing
  - Two-Tone Signal Testing
  - High Frequency Narrow-Band Signal Testing
4. Conclusion

# Bluetooth BR Frequency Measurement

## Bluetooth basic rate (BR)

Carrier frequency:  $2402 + k$  [MHz],  $k = 0, 1, 2, \dots, 78$

Channel space: 1 MHz

Signal: 1 Msps Gaussian Frequency Shift Keying (GFSK)

Bandwidth-Time product (BT): 0.5

Modulation index: 0.28 ~ 0.35

### GFSK signal:

Hopped between 2.402 GHz and 2.480 GHz

Consider frequency hopping signal testing  
by residue sampling

### Residue sampling:

Lower frequency sampling clocks (7, 11, 13, 17 MHz)  
than bandwidth (78 MHz)

# Simulation Conditions

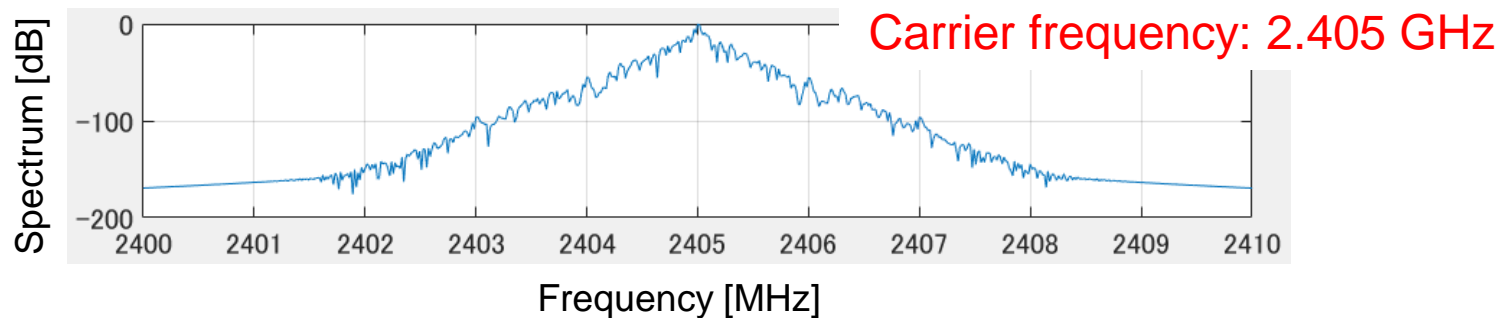
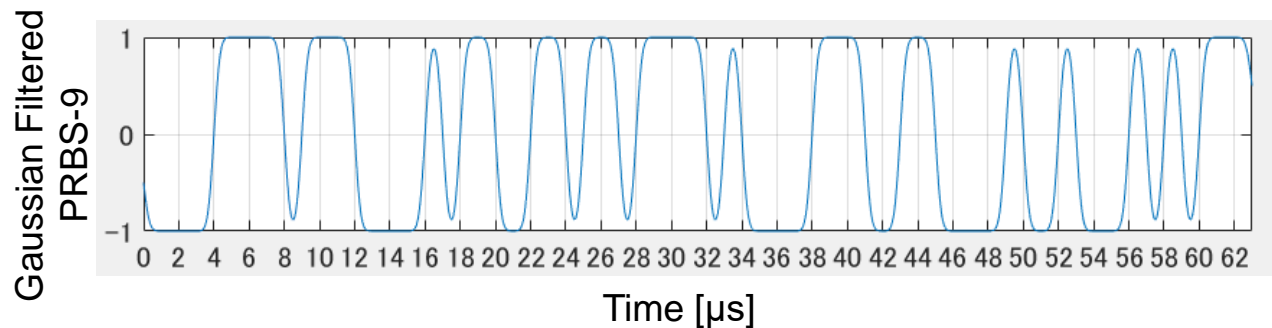
Carrier frequency: 2405 MHz

Signal: Gaussian filtered PRBS-9 (BT = 0.5)

Modulation Index: 0.3

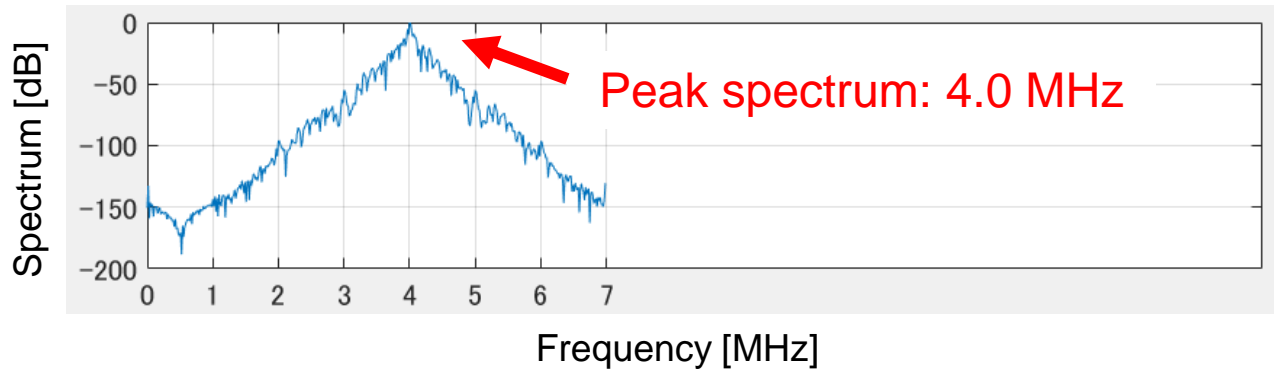
Sampling frequencies:

$$f_{s1} = 7 \text{ MHz}, f_{s2} = 11 \text{ MHz}, f_{s3} = 13 \text{ MHz}, f_{s4} = 17 \text{ MHz}$$



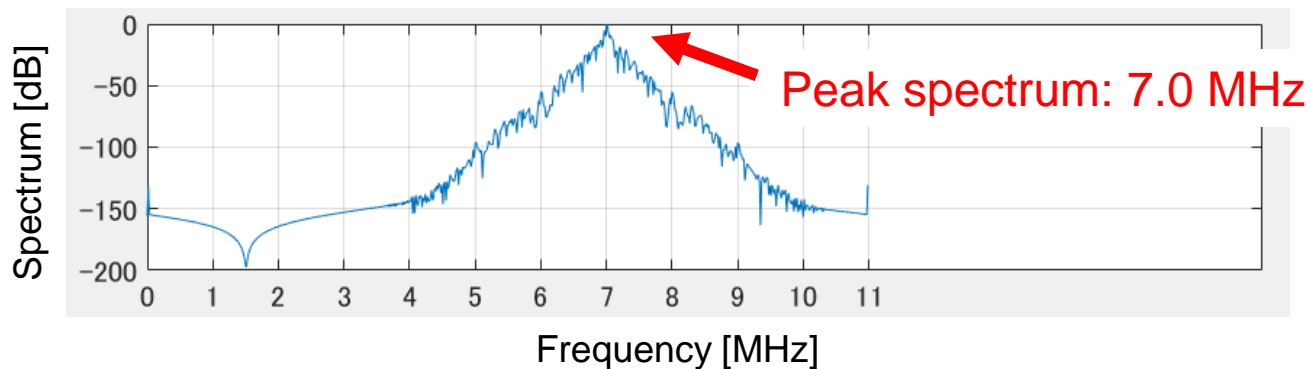
# Bluetooth BR Simulation ( $f_s = 7\text{MHz}, 11\text{MHz}$ )

Sampling frequency:  $f_{s1} = 7\text{ MHz}$



$$\text{mod}_7(2405) = 4$$

Sampling frequency:  $f_{s2} = 11\text{ MHz}$

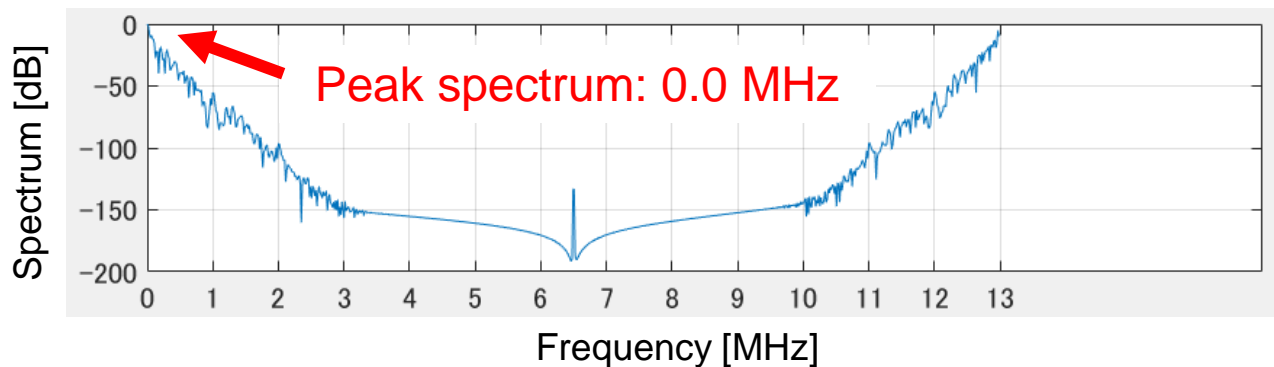


$$\text{mod}_{11}(2405) = 7$$



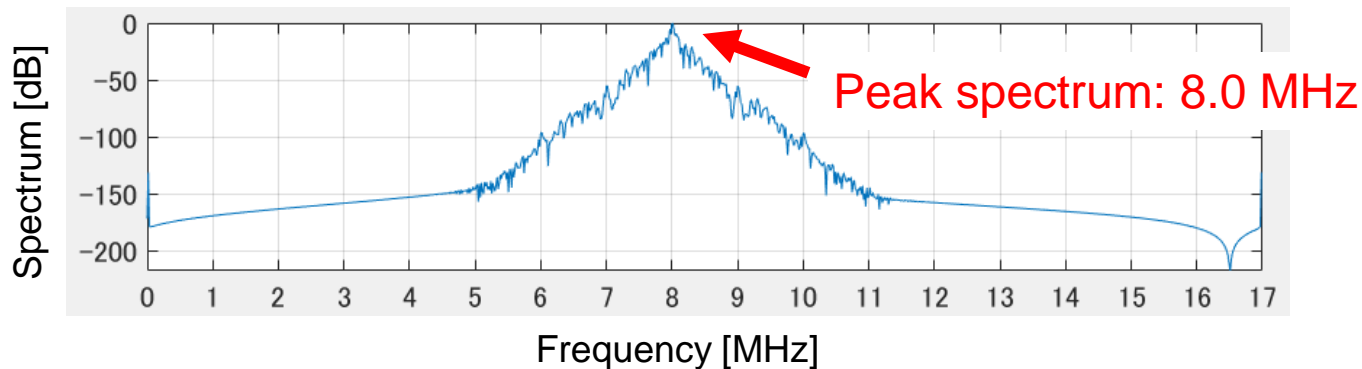
# Bluetooth BR Simulation ( $f_s = 13\text{MHz}, 17\text{ MHz}$ )

Sampling frequency:  $f_{s3} = 13\text{ MHz}$



$$\text{mod}_{13}(2405) = 0$$

Sampling frequency:  $f_{s4} = 17\text{ MHz}$



$$\text{mod}_{17}(2405) = 8$$

Frequency hopping signal testing can be achieved by residue sampling

# Outline

---

1. Research Objective
2. Residue Sampling
  - Chinese Remainder Theorem
  - Residue Sampling Principle
3. Application to RF/AMS Device Testing
  - Two-Tone Signal Testing
  - High Frequency Narrow-Band Signal Testing
4. Conclusion

# Conclusion

- Residue sampling:  
High-frequency signal measurement  
with multiple low-frequency sampling clocks
- Application to RF/AMS device testing
  - Fine frequency resolution measurement  
by large number of sampled data  
(long measurement time)
  - Two-tone signal test:  
Residue HD, IMD power are the same as  
original HD, IMD power
  - High frequency narrow-band signal test:  
Frequency hopping signal testing can be achieved  
with residue sampling.

# Number Theory for RF/AMS Testing



Carolus Fridericus Gauss  
(1777-1855)

*“Number theory is  
the queen of mathematics”*

## Past Number theory

Beautiful and mysterious  
NEVER practical

## Current Number theory

For information communication processing  
➔ good match to digital technology

Number theory application  
for RF/AMS device testing is a frontier.  
There are great chances for new discovering!